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Semiconductor devices - Semiconductor interface for human body communication - Part 1: General requirements (IEC 62779-1:2016)

### iTeh STANDARD PREVIEW

Dispositifs à semi-conducteurs (Interface à semi-conducteurs pour les communications via le corps humain - Partie 1: Exigences générales (IEC 62779-1:2016)

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#### **English Version**

# Semiconductor devices - Semiconductor interface for human body communication - Part 1: General requirements (IEC 62779-1:2016)

Dispositifs à semiconducteurs - Interface à semiconducteurs pour les communications via le corps humain - Partie 1: Exigences générales (IEC 62779-1:2016) Halbleiterbauelemente - Halbleiterschnittstelle zur Kommunikation über den menschlichen Körper -Teil 1: Allgemeine Anforderungen (IEC 62779-1:2016)

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CEN-CENELEC Management Centre: Avenue Marnix 17, B-1000 Brussels

EN 62779-1:2016

### **European foreword**

The text of document 47/2267/FDIS, future edition 1 of IEC 62779-1, prepared by IEC/TC 47 "Semiconductor devices" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN 62779-1:2016.

The following dates are fixed:

- latest date by which the document has to be implemented at (dop) 2016-12-24 national level by publication of an identical national standard or by endorsement
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In the official version, for Bibliography, the following note has to be added for the standard indicated:

IEC 62779 NOTE Harmonized in EN 62779 series.



IEC 62779-1

Edition 1.0 2016-02

# INTERNATIONAL **STANDARD**

# **NORME** INTERNATIONALE



Semiconductor devices - Semiconductor interface for human body Part 1: General requirements (standards.iteh.ai)

SIST EN 62779-1:2016
Dispositifs à semiconducteurs at Interface à semiconducteurs pour les communications via le corps humain et en 62779-1-2016 Partie 1: Exigences générales

INTERNATIONAL **ELECTROTECHNICAL COMMISSION** 

COMMISSION **ELECTROTECHNIQUE INTERNATIONALE** 

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### INTERNATIONAL ELECTROTECHNICAL COMMISSION

SEMICONDUCTOR DEVICES –
SEMICONDUCTOR INTERFACE FOR HUMAN BODY COMMUNICATION –

### Part 1: General requirements

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International Standard IEC 62779-1 has been prepared by IEC technical committee 47:Semiconductor devices.

The text of this standard is based on the following documents:

FDIS	Report on voting
47/2267/FDIS	47/2277/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

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A list of all parts in the IEC 62779 series, published under the general title *Semiconductor devices* – *Semiconductor interface for human body communication*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
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#### INTRODUCTION

The IEC 62779 series is composed of three parts as follow:

- IEC 62779-1 defines general requirements of a semiconductor interface for human body communication. It includes general and functional specifications of the interface.
- IEC 62779-2 defines a measurement method on electrical performances of an electrode that constructs a semiconductor interface for human body communication.
- IEC 62779-3 <sup>1</sup> defines functional type of a semiconductor interface for human body communication, and operational conditions of the interface.

IEC 60748-4 gives requirements on interface integrated circuits for semiconductor devices. Especially, Chapter III, Section 7 in this standard is applied to interface circuits for a communication network using a general channel, such as wire or wireless. However, a channel for HBC is the human body whose channel properties, such as signal loss and delay profile, are different from the general channel, so Chapter III, Section 7 can't be applied to an interface for HBC. Furthermore, a standard on a communication protocol for body area network (BAN) – IEEE 802.15.6, which includes a communication protocol for HBC was published in 2012. A common interface for HBC should be defined to secure communication compatibility between various devices that are implemented on/inside the human body or embedded in peripheral equipments.

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<sup>1</sup> To be published.

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## SEMICONDUCTOR DEVICES – SEMICONDUCTOR INTERFACE FOR HUMAN BODY COMMUNICATION –

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#### Part 1: General requirements

#### 1 Scope

This part of IEC 62779 defines general requirements for a semiconductor interface used in human body communication (HBC). It includes general and functional specifications of the interface, as well as limiting values and its operating conditions.

NOTE Additional information on HBC is provided in Annex A.

#### 2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

None.

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### 3 Terms, definitions and letter symbols

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For the purposes of this document, the following terms and definitions apply.

#### 3.1 General terms

#### 3.1.1

### **HBC** semiconductor interface

semiconductor interface to process an electrical signal that is transmitted to the human body or received from the human body while located between the human body and HBC modem; implemented on/inside the human body and embedded in peripheral equipment

Note 1 to entry: HBC semiconductor interface consists of an electrode and analog front end. The HBC modem converts data into an electrical signal and sends it to the electrode, or receives an electrical signal from the analog front end and converts it into data.

Note 2 to entry: This note applies to the French language only.

#### 3.1.2

#### electrode

physical structure to transmit an electrical signal between an analog front end and the human body while attached to or located near the human body

Note 1 to entry: An electrode transfers an electrical signal to be transmitted to a non-metallic transmission channel, the human body. It also transfers an electrical signal received from the human body to the analog front end.

#### 3.1.3

#### analog front end

semiconductor integrated circuit to recover original data from a receiving signal transmitted through the human body

Note 1 to entry: Analog front end includes a powerline noise reduction filter, a signal amplifier, a high-pass filter, a comparator and a clock and data recovery (CDR) circuit to recover original data transmitted through a non-

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metallic transmission channel. Also, it generates control signals to control operations of each component in the analog front end.

#### 3.1.4

#### powerline noise reduction filter

circuit component in an analog front end to remove a powerline noise signal included in a receiving signal by an antenna function of the human body

Note 1 to entry: Additional information on generation of a powerline noise signal is provided in Annex B.

#### 3.1.5

#### comparator

circuit component in an analog front end to compare two signals and switch its output signal to indicate which is larger

#### 3.1.6

#### **CDR** circuit

circuit component in an analog front end to generate a clock from a receiving signal and align phase of the receiving signal to the generated clock

#### Rating and characteristics 3.2

#### 3.2.1 Input characteristics

#### 3.2.1.1

#### supply voltage

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 $V_{\mathsf{S}}$ 

supply voltage to operate a HBC semiconductor interface

#### 3.2.1.2

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normal mode supply current https://standards.iteh.ai/catalog/standards/sist/759bb11f-9a15-48a8-8aec-

total supply current during normal mode of a HBC semiconductor interface

#### 3.2.1.3

#### disabled mode supply current

total supply current during disabled mode of a HBC semiconductor interface

#### 3.2.1.4

#### input impedance

impedance seen by the human body into a HBC semiconductor interface

Note 1 to entry: Input impedance depends on input impedances of a powerline noise reduction filter, signal amplifier and high-pass filter.

Note 2 to entry: A powerline noise reduction filter removes a high-power noise signal which can saturate the active components in the interface.

#### 3.2.2 **Transfer characteristics**

#### 3.2.2.1

#### sensitivity level

signal's minimum voltage at an input of a HBC semiconductor interface that is required to produce a signal having a specified signal-to-noise ratio at an output

Note 1 to entry: Additional information on the sensitivity level is provided in Annex C.

Note 2 to entry: This note applies to the French language only.